

Deutsche Akkreditierungsstelle

Annex to the Accreditation Certificate D-PL-20284-01-00 according to DIN EN ISO/IEC 17025:2018

Valid from: 18.10.2023Date of issue: 18.10.2023

Holder of accreditation certificate:

Opsytec Dr. Gröbel GmbH Am Hardtwald 6 - 8, 76275 Ettlingen

The testing laboratory meets the requirements of DIN EN ISO/IEC 17025:2018 to carry out the conformity assessment activities listed in this annex. The testing laboratory meets additional legal and normative requirements, if applicable, including those in relevant sectoral schemes, provided that these are explicitly confirmed below.

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of testing laboratories and they conform to the general principles of DIN EN ISO 9001.

Testing in the field:

Spectroradiometers and spectrometers

Lighting technology

The testing laboratory is permitted, without being required to inform and obtain prior approval from DAkkS, to use standards or equivalent testing methods listed here with different issue dates. The testing laboratory maintains a current list of all testing methods within the flexible scope of accreditation.

This certificate annex is only valid together with the written accreditation certificate and reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH at https://www.dakks.de.

Abbreviations used: see last page



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Standard / Publication date	Title of Standard	Testing Conditions / Limitations
CIE 250:2022	Spectroradiometric Measurement of Optical Radiation Sources	lamps, light sources, radiation sources, semiconductor sources, radiation and semiconductor systems/irradiance in the wavelength range from 200 nm to 1000 nm
IEC 62471-6:2022	Photobiological safety of lamps and lamp systems - Part 6: Ultraviolet lamp products	lamps, light sources, radiation sources, semiconductor sources, radiation and semiconductor systems
ASTM G138-12 2020	Standard Test Method for Calibration of a Spectroradiometer Using a Standard Source of Irradiance	spectroradiometer / device properties at defined device settings at in the wavelength range from 200 nm to 2500 nm

Abbreviations used:

ASTM American Society for Testing and Materials

CIE Commission Internationale de l'Éclairage

DIN Deutsches Institut für Normung e.V. – German institute for standardization

EN Europäische Norm – European Standard

IEC International Electrotechnical Commission
ISO International Organization for Standardisation

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